*TB 9-6625-2235-24 DEPARTMENT OF THE ARMY TECHNICAL BULLETIN CALIBRATION PROCEDURE FOR SPECTRUM ANALYZER

HEWLETT-PACKARD, MODEL 8558B Headquarters, Department of the Army, Washington, DC

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REPORTING OF ERRORS AND RECOMMENDING IMPROVEMENTS

You can improve this manual. If you find any mistakes or if you know of a way to improve these procedures, please let us know. Mail your letter or DA Form 2028 (Recommended Changes to Publications and Blank Forms) directly to: Commander, U.S. Army Aviation and Missile Command, ATTN: AMSAM-MMC-MA-NP, Redstone Arsenal, AL 35898-5000. A reply will be furnished to you. You may also send in your comments electronically to our E-mail address: 2028@redstone.army.mil or by fax 256-842-6546/DSN 788-6546. For the World Wide Web use: https://amcom2028.redstone.army.mil. Instructions for sending an electronic 2028 can be found at the back of this manual.

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^{*}This technical bulletin supersedes TB 9-6625-2235-35 dated 3 December 1990.

SECTION I IDENTIFICATION AND DESCRIPTION

1. Test Instrument Identification. This bulletin provides instructions for the calibration of Spectrum Analyzer, Hewlett-Packard, Model 8558B. The manufacturer's manual was used as the prime data source in compiling these instructions. The equipment being calibrated will be referred to as the TI (test instrument) throughout this bulletin.

a. Model Variations. None.

b. Time and Technique. The time required for this calibration is approximately 6 hours, using the dc and low frequency and microwave technique

2. Forms, Records, and Reports

a. Forms, records, and reports required for calibration personnel at all levels are prescribed by TB 750-25.

b. Adjustments to be reported are designated (R) at the end of the sentence in which they appear. When adjustments are in tables, the (R) follows the designated adjustment. Report only those adjustments made and designated with (R).

3. Calibration Description. TI parameters and performance specifications which pertain to this calibration are listed in table 1.

Test instrument parameters	Performance specifications				
Calibrator	Frequency: 280 MHz				
	Power output: -30 dBm				
	Frequency accuracy: ± 300 kHz (SN 2118A and below ±50 kHz)				
	Power output accuracy: ±1 dBm				
Sweep time	Range: 0.1 ms/div to 50 ms				
_	Accuracy: ±10%				
Span width	Frequency range: 5 kHz to 100 MHz				
	Accuracy: Frequency error between any two points is less than ±5% of the				
	indicated frequency separation				
Frequency	Range: 100 kHz to 1500 MHz				
	Accuracy: 0 to 195 MHz, ±(1 MHz +20% of freq span/div switch setting) 195 to				
	1500 MHz, ±(5 MHz +20% of freq span/div switch setting)				
Resolution bandwidth	Range: 1 kHz to 3 MHz				
Accuracy: ±20%					
Input attenuator	Range: 0 to 70 dB at 30 MHz				
_	Accuracy: ±.5 dB per 10 dB step				
	Maximum cumulate error: 0 to 70 dB <±1.0 dB				

— ·	Table 1. Cambration Description - Continued				
Test instrument parameters	Performance specifications				
Reference level	Range: -112 to +60 dBm				
	Step accuracy: Steps referenced with 0 dB input attenuation:				
-10 to -80 dBm: ±0.5 dB					
	-10 to -100 dBm: ±1.0 dB				
	Vernier accuracy: ±0.5 dB				
Frequency response	Range: 100 kHz to 1500 MHz				
	Accuracy: ±1 dB with 10 dB input attenuation				
Residual FM	Less than 1 kHz peak-to-peak for time < 0.1 s				
Noise sidebands	Sidebands existing more than 50 kHz from 400 MHz signal will be more than -65				
	dB from reference with 1 kHz resolution bandwidth and full video filtering				

Table 1. Calibration Description - Continued

SECTION II EQUIPMENT REQUIREMENTS

4. Equipment Required. Table 2 identifies the specific equipment to be used in this calibration procedure. This equipment is issued with Secondary Transfer Calibration Standards Set AN/GSM-286; AN/GSM-287 or AN/GSM-705. Alternate items may be used by the calibrating activity when the equipment listed in table 2 is not available. The items selected must be verified to perform satisfactorily prior to use and must bear evidence of current calibration. The equipment must meet or exceed the minimum use specifications listed in table 2. The accuracies listed in table 2 provide a four-to-one ratio between the standard and TI. Where the four-to-one ratio cannot be met, the four-to-one accuracy will be listed, and the actual accuracy of the equipment selected is shown in parenthesis.

5. Accessories Required. The accessories required for this calibration are common usage accessories, issued as indicated in paragraph 4 above, and are not listed in this calibration procedure. The following peculiar accessories are also required for this calibration and must be supplied with TI: Display Mainframe, Hewlett-Packard, Model 180 series with 807 Option and Extender Cable Assembly, Hewlett-Packard, Model 5060-0303.

Common name	Minimum use specifications	Manufacturer and model (part number)	
ATTENUATOR (FIXED)	Range: 10 dB Frequency: 100 kHz to 1500 MHz Accuracy: ±0.5 dB	Weinschel, Model 9918-10 dB (9918-10dB)	
COMB GENERATOR	Frequency: 500 to 1500 MHz Accuracy: ±0.5%	Tektronix, Type 067-0885-00 (067-0885-00)	
FREQUENCY COUNTER	Range: 0.9 to 540 ms Accuracy: ±1.9% Range: 279.7 to 280.05 MHz Accuracy: ±0.005%	Fluke, Model PM6681/656 (PM6681/656)	

Table 2. Minimum Specifications of Equipment Required

Table	2. Minimum Specifications of Equipment Ro	
<i></i>	Minimum use	Manufacturer and model
Common name	specifications	(part number)
MEASURING RECEIVER	Range: 0 to 75.5 dB	Measuring receiver system N5530S
	Frequency: 0.30 GHz	consisting of: Spectrum Analyzer, Agilent
	Accuracy: ±0.125 dB	Model E4440A (E4440A), Power meter,
		Agilent Model E4419B (E4419B), and
		Sensor module, Agilent Model N5532A
		opt. 504 (504)
MULTIMETER	Range: 92 mV to 14.52 V dc	Hewlett-Packard, Model 3458A (3458A)
	Accuracy: ±0.03%	
OSCILLOSCOPE	Time: 2 ms per division	(OS-303/G)
	Amplitude: 2 V per division	
	Range: -5 to +5 V dc	
	Accuracy: ±3%	
POWER METER	Frequency range: 10 to 1500 MHz	Hewlett-Packard, Model E12-432A
	Accuracy: ±.25 dB (±.7 dB)	(MIS-30525) w/thermistor mount,
	Power range: -16.7 to - 10 dBm	Hewlett-Packard, Model H75-478A
		(7915907) or 8478B (8478B)
POWER SPLITTER	Frequency range: 279.7 to 280.3 MHz	Weinschel, Model 1870A
	Output tracking between ports: ±0.15 dB	(7916839)
SIGNAL GENERATOR	Range: 80 to 1505.2 MHz	Aeroflex, Model 2023B (2023B) or
	Accuracy: ±0.09%	SG-1207/U
	Power range: +10 to -30 dBm	
SYNTHESIZER/LEVEL	Range: 5 kHz to 80 MHz	Hewlett-Packard, Model 3335AOPT
GENERATOR	Accuracy: Frequency $\pm 0.5\%$	001-KO6 (MIS-35938)
	Flatness ±.25 dB	
	Amplitude range: -70.5 to 10 dBm	
VARIABLE	Range: 0 to 60 dB	Weinschel, Model AF117A-69-34
ATTENUATOR	Accuracy: ±0.02 dB per 10 dB step with	(AF117A-69-34)
	correction chart	

Table 2. Minimum Specifications of Equipment Required - Continue	Table 2.	Minimum	Specifications	of Equipment	Required - Contin	ued
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SECTION III CALIBRATION PROCESS

6. Preliminary Instructions

a. The instructions outlined in paragraphs 6 and 7 are preparatory to the calibration process. Personnel should become familiar with the entire bulletin before beginning the calibration.

b. Items of equipment used in this procedure are referenced within the text by common name as listed in table 2.

c. Unless otherwise specified, verify the result of each test and, whenever the test requirement is not met, take corrective action before continuing with the calibration. Adjustments required to calibrate the TI are included in this procedure. Additional maintenance information is contained in the manufacturer's manual for this TI.

d. Unless otherwise specified, all controls and control settings refer to the TI.

7. Equipment Setup

NOTE

HIGH VOLTAGE is used or exposed during the performance of this calibration. DEATH ON CONTACT may result if personnel fail to observe safety precautions. REDUCE OUTPUT(S) to minimum after each step within the performance check where applicable.

CAUTION

To avoid damage to test instrument do not exceed +30 dBm, (1 W, 7.1 V rms) to INPUT 50 Ω connector.

Do not use **FIND BEAM** control of display mainframe when TI is installed in oscilloscope.

a. Press display mainframe LINE pushbutton to OFF position.

b. Install extender cable (Hewlett-Packard, Model 5060-0303) between TI and display mainframe. Remove orange (pin 3) and yellow (pin 4) on A15 board (spectrum analyzer rear) and connect extender cable insulated alligator clips to pins 3 and 4.

c. Connect display mainframe to ac power source and press **LINE** pushbutton to **ON** position. Allow TI to warm-up for 30 minutes.

d. Position controls as listed in (1) through (12) below:

(1) **INPUT ATTEN (dB)** switch to **10 dB** (push knob to engage) (for older plugins, **OPTIMUM INPUT** to **-30 dBm)**.

- (2) **REFERENCE LEVEL** switch to **0 dBm**.
- (3) **REF LEVEL FINE** control to **0 dBm**.
- (4) Press **LIN** pushbutton in.
- (5) **FREQ SPAN/DIV** switch to **10 MHz** (uncoupled).
- (6) **RESOLUTION BW** switch to 1 MHz (uncoupled).
- (7) SWEEP TIME/DIV switch to AUTO.
- (8) SWEEP TRIGGER switch to FREE RUN.
- (9) **CENTER-START** pushbutton to **CENTER**.
- (10) **TUNING** control to **>60 MHz**.

(11) BASELINE CLIPPER control to OFF position.

(12) VIDEO FILTER control to OFF position.

- e. Position display mainframe controls as listed in (1) through (5) below:
 - (1) **DISPLAY** switch to **INT**.
 - (2) **MAGNIFIER** switch to **X1**.
 - (3) SCALE (180TR, 182T) control to OFF.
 - (4) **PERSISTENCE (181T/TR)** control to **MIN**.

(5) **DISPLAY MODE (180T/TR) switch** to **WRITE**.

f. Position crt trace on horizontal graticule line near crt center with **VERTICAL POSN** control and reduce amount of intensity to prevent burning crt phosphor.

g. Set SWEEP TIME/DIV switch to MAN and center crt dot with MAN SWEEP control.

CAUTION

A high intensity dot left on crt for prolonged periods can burn the phosphor.

h. Adjust FOCUS and ASTIG controls for smallest round dot possible.

i. Set SWEEP TIME/DIV switch to AUTO and increase amount of intensity for an optimum crt trace.

j. Center crt trace with **HORIZONTAL POSITION** control. Adjust **HORIZ GAIN** control (located on TI rear panel) for exactly 10 divisions.

k. Position crt trace parallel to horizontal graticule line with **TRACE ALIGN** control, and adjust **VERTICAL POSN** control to align crt trace with bottom graticule line.

l. Center **LO** feedthrough signal on crt with **TUNING** control and press **FREQUENCY CAL** pushbutton three times.

m. Set FREQ SPAN/DIV switch to 200 kHz and press FREQUENCY CAL pushbutton.

n. Position signal peak near top crt graticule line with **REF LEVEL FINE** control.

o. Center LO feedthrough signal on crt with TUNING control and adjust FREQUENCY ZERO control for 00.0 MHz indication on FREQUENCY MHz readout display.

p. Set FREQ SPAN/DIV switch to 1 MHz and REF LEVEL FINE control to 0.

q. Adjust TUNING control for FREQUENCY MHz indication of approximately 280 MHz.

r. Press 10 dB/DIV pushbutton in and set REFERENCE LEVEL switch to -20 dBm.

s. Connect 280 MHz CAL OUTPUT to TI INPUT 50Ω.

t. Center signal on crt with TUNING control and press FREQUENCY CAL pushbutton three times. FREQUENCY MHz readout will indicate between 275 and 285 MHz.

u. Press **LIN** pushbutton in.

v. Position signal peak at top crt graticule line with **REF LEVEL FINE** control.

w. Press **10 dB/DIV** pushbutton in and adjust **VERTICAL GAIN** control to position signal peak at top crt graticule line.

x. Repeat (u) through (w) above until signal peak remains at top crt graticule line when amplitude scale is changed from **10 dB/ DIV** to **LIN** and back to **10dB/DIV**.

y. Set REF LEVEL FINE control to 0, and REFERENCE LEVEL switch to -30 dBm.

z. Press LIN pushbutton in and position signal peak at top crt graticule line with **REF** LEVEL CAL control.

NOTE

Refer to major assembly location (fig. 1) for board location.

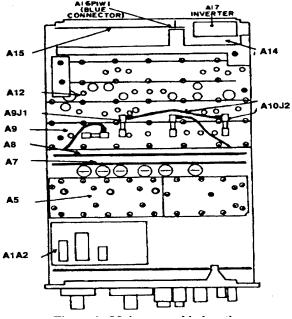


Figure 1. Major assembly locations.

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8. Calibrator Output Accuracy

a. Performance Check

(1) Connect 280 MHz CAL OUTPUT to INPUT 50Ω.

(2) Center 280 MHz signal on crt with ${\bf TUNING}$ control and press ${\bf FREQUENCY}$ CAL pushbutton.

NOTE

Adjust **INPUT ATTEN** control (if necessary) for a measurable signal.

(3) Press in 1 dB/DIV pushbutton and recenter signal on crt with TUNING control.

(4) Position signal peak on top crt graticule line with **REFERENCE LEVEL** and **REF LEVEL FINE** controls.

NOTE

Signal position and amplitude established in (3) and (4) above will be used as references in (7) below.

(5) Disconnect **280 MHz CAL OUTPUT** to **INPUT 50** Ω and connect equipment as shown in figure 2 (connection A).

(6) Set variable attenuator to 20 dB.

(7) Adjust signal generator frequency and power output level to match references established in (3) and (4) above.

(8) If power meter indication is not between -9 and -11 dBm, perform ${\bf b}$ (1) through (3) below.

NOTE

Variable attenuator and power splitter errors must be included in (8) above.

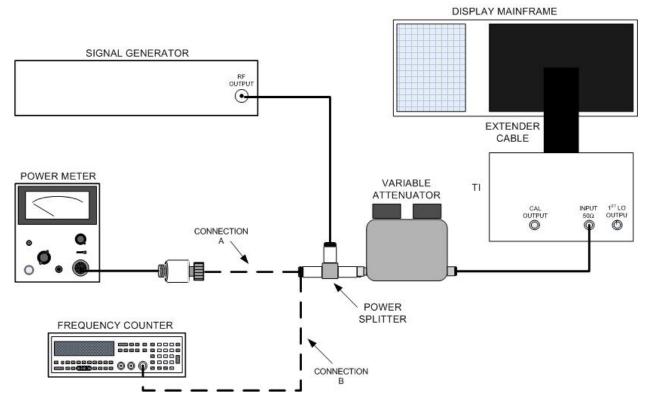


Figure 2. Calibrator levels - equipment setup.

(9) Connect equipment as shown in figure 2 (connection B). If frequency counter does not indicate between 279.7 and 280.3 MHz (SN 2118A and below, 279.95 and 280.05 MHz), perform **b** (4) through (6) below.

b. Adjustments

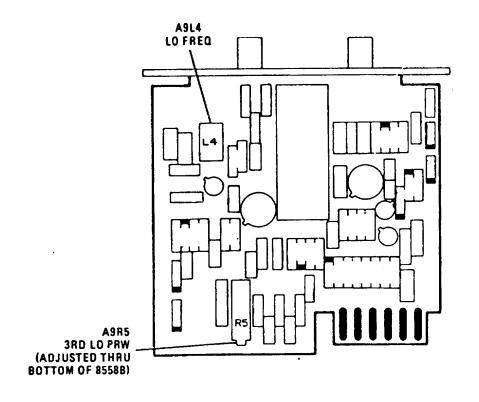
(1) Adjust signal generator frequency to 280 MHz and output RF level for a -10 dBm indication on power meter. Record signal position and amplitude on crt.

NOTE

Variable attenuator and power splitter errors must be included in \mathbf{b} (1) above.

(2) Disconnect equipment as shown in figure 2 and connect 280 MHz CAL OUTPUT to INPUT 50Ω .

- (3) Adjust A9R5 (fig. 3) to position signal peak to reference established in (1) above (R).
- (4) Connect CAL OUTPUT to INPUT 50Ω .
- (5) Center 280 MHz signal on TI display.



(6) Adjust A9L4 (fig. 3) for a maximum signal amplitude indication on TI display (R).

Figure 3. Adjustment location.

9. Sweep Time

a. Performance Check

(1) Connect equipment as shown in figure 4.

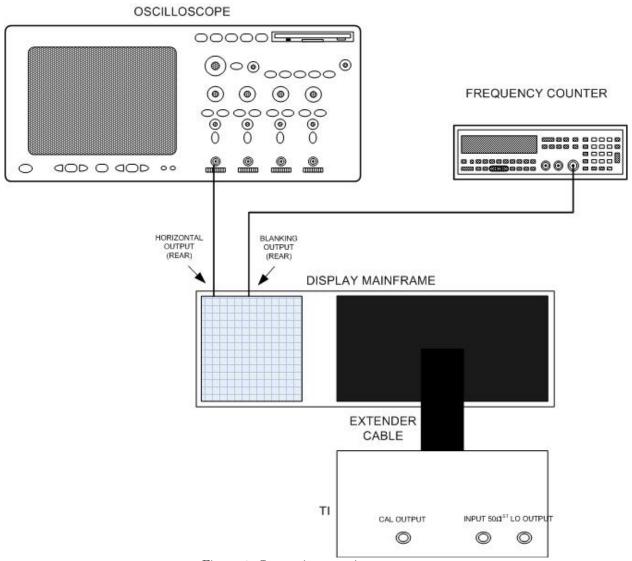


Figure 4. Sweep time - equipment setup.

(2) Set SWEEP TIME/DIV switch to 1 ms and SWEEP TRIGGER switch to FREE RUN.

(3) Measure ramp and dead time with oscilloscope. Ramp voltage will be approximately -5 to +5 V and dead time will be between 0.25 and 0.40 ms. Record actual dead time value.

(4) Set **SWEEP TIME/DIV** switch to **5 ms (2 ms** for SN prefixed 2215A and below). Measure and record dead time of ramp. Dead time of ramp will be between 6 and 9 ms.

(5) Set **SWEEP TIME/DIV** switch to **1 ms**. If frequency counter does not indicate 10 ms + dead time of ramp [(3) above] ± 0.8 Ms, perform **b** (1) below.

(6) Set **SWEEP TIME/DIV** switch to **5 ms (2 ms** for SN prefixed 2215A and below). If frequency counter does not indicate 50 ms + dead time of ramp [(4) above] ± 4.0 ms (20 ms + dead time of ramp [(4) above] ± 1.5 ms for SN prefixed 2215A and below), perform b (2) below.

(7) Set **SWEEP TIME/DIV** switch to settings listed in table 3, and after subtracting dead time from frequency counter indication. If difference is not within specified limits, perform the listed adjustment step.

Table 3. Sweep Time						
Test ins	strument	Frequency counter period indication minus dead time (ms)				
SWEEP TIME/DIV switch	Dead time			Adjustment step		
settings (ms)	(step)	Min	Max	(b)		
.1	3	0.9	1.1	1		
.2	3	1.8	2.2	1		
.5	3	4.6	5.4	1		
1	3	9.2	10.8	1		
2	4	18.5	21.5	1		
5	4	46	54	2		
10	4	92	108	2		
20	4	184	216	2		
50	4	460	540	2		

b. Adjustments

NOTE

Repeat measurements and adjustments as listed in table 3 until all sweep times are within specified limits.

Adjustments for SN prefix 2215A and below are shown at figure 5 and SN prefix 2332A are shown at figure 6.

(1) Subtract dead time value recorded in (3) above from frequency counter indication and adjust A8R10 (SN prefix 2215A and below, fig. 5) or (SN prefix 2332A, fig. 6) for frequency counter in limits indication listed in table 3.

(2) Subtract dead time recorded in (4) above from frequency counter indication and adjust A8R13 (SN prefix 2215A and below, fig. 5) or (SN prefix 2332A, fig. 6) for frequency counter in limits indication listed in table 3.

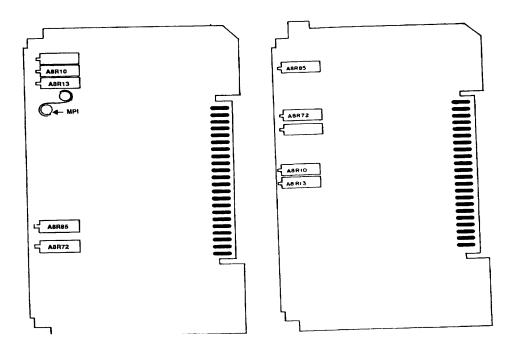
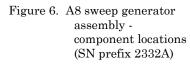


Figure 5. A8 sweep generator - component and test point locations (SN prefix 2215A and below



10. Span Width and Frequency Accuracy

a. Performance Check

- (1) Connect equipment as shown in figure 7.
- (2) Position controls as listed in (a) through (g) below.
 - (a) FREQ SPAN/DIV switch to 20 MHz.
 - (b) **RESOLUTION BW** (**RES BW**) switch pushed in to **OPTIMUM** (coupled).
 - (c) INPUT ATTEN switch to 0 dB (OPTIMUM INPUT switch to -40 dBm).
 - (d) **REFERENCE LEVEL** switch to -20 dBm.
 - (e) 10 dB/DIV pushbutton pressed in.
 - (f) **TIME/DIV** switch to **AUTO**.

(g) SWEEP TRIGGER switch to FREE RUN.

(3) Position LO feedthrough signal on center crt vertical graticule line with TUNING control.

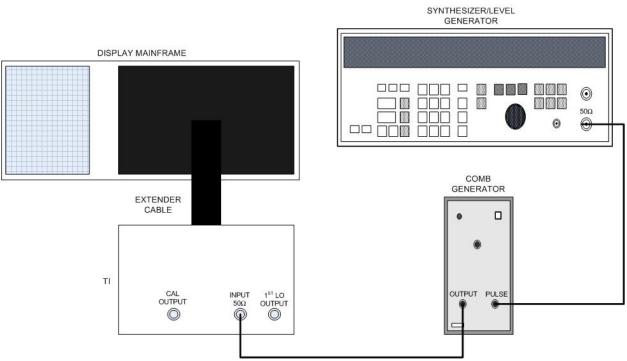


Figure 7. Span width and frequency accuracy - equipment setup.

(4) Depress **FREQUENCY CAL** pushbutton and adjust **FREQUENCY ZERO** control for zero indication on **FREQUENCY MHz** readout.

(5) Repeat (3) and (4) above until **LO** feedthrough signal remains positioned on center vertical graticule line of crt.

(6) Adjust synthesizer/level generator frequency to 20 MHz and amplitude output level to +10 dBm.

(7) Adjust TUNING control for 500 MHz indication on FREQUENCY MHz readout.

(8) Press **FREQUENCY CAL** pushbutton and center 500 MHz comb signal on crt with **TUNING** control.

(9) Adjust **RESOLUTION BW** and **INPUT ATTEN** (**OPTIMUM INPUT**) switches to view 20 MHz comb signal on crt.

(10) Adjust **TUNING** control to position a 20 MHz comb signal on 1st vertical graticule line (fig. 8).

(11) Press FREQUENCY CAL pushbutton.

(12) Repeat (10) above.

(13) The 9th spectral signal will be within ± 0.4 division of 9th vertical graticule line (fig. 8); if not, perform **b** below.

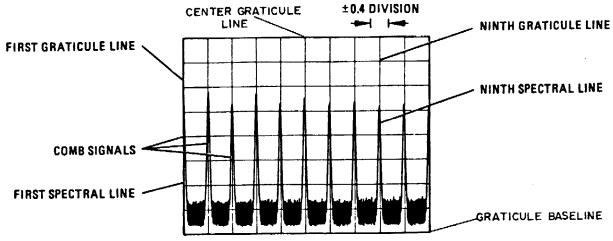


Figure 8. Frequency span accuracy measurement for 9th spectral line.

(14) Repeat technique of (10) through (13) above for **FREQ SPAN/DIV** switch settings and synthesizer/level generator frequencies as listed in table 4.

NOTE Adjust **RESOLUTION BW** switch, as necessary, to view signal.

(15) Disconnect synthesizer/level generator output from pulse 50Ω input of comb generator and set FREQ SPAN/DIV switch to 100 MHz.

Table 4. Frequency Span Accuracy					
Test instrument	Synthesizer/level				
FREQ SPAN/DIV	generator				
switch settings	frequencies				
10 MHz	10 MHz				
5 MHz	5 MHz				
2 MHz	2 MHz				
1 MHz	1 MHz				
500 kHz	500 kHz				
100 kHz	100 kHz				
20 kHz	20 kHz				
5 kHz	5 kHz				

(16) Adjust **TUNING** control for **1000 MHz** indication on **FREQUENCY MHz** display and position a 500 MHz comb signal on lst vertical graticule line (fig. 8).

(17) Press FREQUENCY CAL pushbutton and repeat (16) above.

(18) If the second comb signal (1000 MHz) is not within ± 0.2 division of center vertical graticule line (fig. 8), perform **b** below.

(19) Center LO feedthrough signal on crt with TUNING control.

(20) Press **FREQUENCY CAL** pushbutton and repeat (19) above.

(21) Adjust **FREQUENCY ZERO** control for 00.00 indication on **FREQUENCY MHz** readout.

(22) Disconnect comb generator output from **TI INPUT 5OΩ**.

(23) Connect synthesizer/level generator 50Ω output to **TI INPUT 50** Ω .

(24) Adjust synthesizer/level generator frequency to 2 MHz and output amplitude level to -10 dBm.

(25) Set FREQ SPAN/DIV switch to 100 kHz.

(26) Adjust TUNING control for 2 MHz indication on FREQUENCY MHz readout.

NOTE Adjust INPUT ATTEN (OPTIMUM INPUT) switch for workable signal level.

(27) Press FREQUENCY CAL pushbutton.

(28) Center signal on crt with synthesizer/level generator frequency controls. If synthesizer/level generator indication is not between .980 and 3.02 MHz, perform **b** below.

(29) Repeat technique of (24) through (28) above for **FREQUENCY MHz** readout, **FREQ SPAN/DIV** switch settings, synthesizer/level generator, and signal generator frequencies listed in table 5.

Table 5. Frequency Accuracy						
Test ins	trument					
FREQUENCY	FREQ SPAN/DIV	Synthesizer/level generator				
MHz	switch	or signal generator frequency				
readout		(M	Hz)			
(MHz)	settings	Min	Max			
10	200 kHz	8.96	11.04			
50	200 kHz	48.96	51.04			

Table 5. Frequency Accuracy

Test instrument				
FREQUENCY MHz readout	FREQ SPAN/DIV switch		Synthesizer/level generator or signal generator frequency (MHz)	
(MHz)	sett	ings	Min	Max
1001	200	kHz	98.96	101.04
140	200	kHz	138.96	141.04
180	200	$\rm kHz$	178.96	181.04
200	1	MHz	194.8	205.2
400	1	MHz	394.8	405.2
600	1	MHz	594.8	605.2
800	1	MHz	794.8	805.2
1000	1	MHz	994.8	1005.2
1200	1	MHz	1194.8	1205.2
1400	1	MHz	1394.8	1405.2
1500	1	MHz	1494.8	1505.2

Table 5. Frequency Accuracy - Continued

¹Replace synthesizer/level generator with signal generator.

b. Adjustments

(1) Connect multimeter to A7TP7 (fig. 9) and chassis ground. Adjust A7R5 (fig. 9) for a multimeter indication between 14.48 and 14.52 V dc (R).

(2) Disconnect multimeter from A7TP7 (fig. 9) and connect to A7TP6 (fig. 9) and adjust A7R4 (fig. 9) for a multimeter indication between 5.99 and 6.01 V dc (R).

(3) Set FREQ SPAN/DIV switch to 5 MHz and RESOLUTION BW switch to 100 kHz.

(4) Turn **FREQUENCY ZERO** control fully ccw.

(5) Adjust TUNING control for FREQUENCY MHz readout of approximately -16.0.

(6) Press **FREQUENCY CAL** pushbutton and adjust A7R3 (fig. 9) to center **LO** feedthrough (within ± 1 division) on crt (R).

NOTE

Press **FREQUENCY CAL** pushbutton whenever **TUNING** control is adjusted. Disconnect comb generator, when necessary, to center **LO** feedthrough.

- (7) Position controls as listed in (a) through (d) below:
 - (a) **FREQ SPAN/DIV** switch in to couple position.
 - (b) **RESOLUTION BW** switch in to couple position.
 - (c) **FREQ SPAN/DIV** switch to **100 MHz/DIV**.

- (d) TUNING control to 500 MHz indication on FREQUENCY MHz readout.
- (8) Connect comb generator to TI **INPUT 50** Ω .

(9) Adjust **TUNING** control, A7R1 and A7R2 (fig. 9) to position a comb signal on lst vertical graticule line and a second comb signal on 6th (center) vertical graticule line (R).

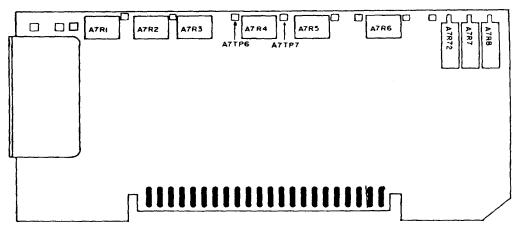


Figure 9. A7 frequency control - adjustment locations.

(10) Repeat (5) and (6) above.

(11) Connect equipment as shown in figure 7.

(12) Adjust synthesizer/level generator frequency to 1 MHz and RF output amplitude to +10 dBm.

(13) Set FREQ SPAN/DIV switch to 1 MHz.

(14) Adjust **TUNING** control to approximately 11 MHz for view of one comb signal per division and press **FREQUENCY CAL** pushbutton.

(15) Adjust A7R6 (fig. 9) to align comb signals (one per division) on vertical graticule lines (R).

(16) Disconnect equipment shown in figure 7 and connect signal generator RF output to TI **INPUT 50** Ω .

(17) Adjust signal generator frequency to 1500 MHz and RF output level to -10 dBm.

NOTE

RF output level for signal generator will remain at -10 dBm for frequencies of 190 and 200 MHz.

(18) Set FREQ SPAN/DIV switch to 500 kHz.

(19) Center LO feedthrough signal on crt with TUNING control.

(20) Press FREQUENCY CAL pushbutton.

(21) Repeat (19) above.

(22) Adjust FREQUENCY ZERO control for 00.0 indication on FREQUENCY MHz readout.

(23) Adjust **INPUT ATTEN (OPTIMUM INPUT)** switch for workable signal level on crt.

(24) Adjust TUNING control to center 1500 MHz signal on crt.

(25) Press **FREQUENCY CAL** pushbutton and recenter 1500 MHz signal with **TUNING** control. Adjust A1A2R3 (located on A1A2 board) for **FREQUENCY MHz** readout indication between 1499 and 1501 MHz (R).

(26) Adjust signal generator frequency to 190 MHz.

(27) Adjust TUNING control to center 190 MHz signal on crt.

(28) Press FREQUENCY CAL pushbutton.

(29) Repeat (27) above and adjust A7R7 (fig. 9) for **FREQUENCY MHz** readout indication of 190.0 (R).

(30) Adjust **TUNING** control for **FREQUENCY MHz** readout indication of 198.5 and slowly adjust A7R8 (fig. 9) ccw until range switches (no decimal on **FREQUENCY MHz** readout (R).

(31) Center LO feedthrough signal on crt with TUNING control.

(32) Press FREQUENCY CAL pushbutton.

(33) Repeat (31) above.

(34) Adjust signal generator frequency to 200 MHz.

(35) Center 200 MHz signal on crt with TUNING control.

(36) Press FREQUENCY CAL pushbutton.

(37) Repeat (35) above and adjust A7R72 (fig. 9) for **FREQUENCY MHz** readout indication of 200.0 (R).

(38) Repeat (17) through (37) above until 190.0, 200, and 1500 MHz readout indications are within specified limits on **FREQUENCY MHZ** readout.

11. Resolution Bandwidth Accuracy

a. Performance Check

- (1) Position controls as listed in (a) through (h) below:
 - (a) **TUNING** control to **10 MHz**.
 - (b) **FREQ SPAN/DIV** switch to **0**.
 - (c) **RESOLUTION BW** switch to **3 MHz**.
 - (d) INPUT ATTEN switch to 20 dB (OPTIMUM INPUT switch to -20 dBm).
 - (e) **REFERENCE LEVEL** switch to **0 dBm**.
 - (f) **LIN** pushbutton pressed in.
 - (g) SWEEP TIME/DIV switch to 5 Ms.
 - (h) SWEEP TRIGGER switch to FREE RUN.
- (2) Connect synthesizer/level generator 50Ω output to TI **INPUT** 50Ω .

(3) Adjust synthesizer/level generator frequency to 10 MHz and output amplitude power level to 0 dBm.

(4) Adjust **TUNING** control to center 10 MHz signal peak on crt. (Reduce synthesizer/level generator output amplitude, if necessary.

(5) Adjust synthesizer/level generator output amplitude control to position trace 7.1 divisions above graticule baseline.

(6) Increase synthesizer/level generator frequency until trace drops to 5 divisions above graticule baseline and record synthesizer/level generator frequency.

(7) Adjust synthesizer/level generator frequency in direction opposite to that in (6) above until trace peaks (7.1 divisions above graticule baseline) and then drops to 5 divisions above graticule baseline. Record synthesizer/level generator frequency.

(8) Subtract frequency recorded in (7) above from frequency recorded in (6) above. If difference is not between 2.40 and 3.60 MHz, perform **b** below.

(9) Set **RESOLUTION BW** switch to 1 MHz and repeat (3) through (8) above. If difference is not between 800 and 1200 kHz, perform \mathbf{b} below.

(10) Set **RESOLUTION BW** switch to **300** \mathbf{kHz} and repeat (3) through (8) above. If difference is not between 240 and 360 kHz, and perform **b** below.

(11) Set **RESOLUTION BW** switch to **100** \mathbf{kHz} and repeat (3) through (8) above. If difference is not between 80 and 120 kHz, and perform **b** below.

(12) Disconnect synthesizer/level generator **50Ω OUTPUT** from TI.

(13) Disconnect W7 (red) cable (fig. 1) from A10J2 connector (fig. 1) and connect signal generator RF output to W7 (red) cable (fig. 1).

(14) Adjust signal generator frequency to 301.4 MHz and RF output level to -12 dBm.

(15) Position controls as listed in (a) through (c) below:

- (a) INPUT ATTEN switch to 0 dB (OPTIMUM INPUT switch to -40 dBm).
- (b) **REFERENCE LEVEL** switch to **-10 dBm**.

(c) **RESOLUTION BW** to **30 kHz**.

(16) Adjust signal generator frequency until TI trace is at peak and adjust signal generator RF output level control to position trace 7.1 divisions above graticule baseline.

(17) Increase signal generator frequency until trace drops to 5 divisions above graticule baseline. Record signal generator frequency.

(18) Adjust signal generator frequency in direction opposite to that of (17) above until trace peaks and then drops to 5 divisions above graticule baseline. Record signal generator frequency.

(19) Subtract frequency recorded in (18) above from (17) above. If difference is not between 24 and 36 kHz, perform \mathbf{b} below.

(20) Set **RESOLUTION BW** switch to **10 kHz** and repeat (16) through (19) above. If difference is not between 8 and 12 kHz, perform **b** below.

(21) Set **RESOLUTION BW** switch to **3 kHz** and repeat (16) through (19) above. If difference is not between 2.4 and 3.6 kHz, perform **b** below.

(22) Set **RESOLUTION BW** switch to 1 \mathbf{kHz} and repeat (16) through (19) above. If difference is not between 0.8 and 1.2 kHz, perform **b** below.

(23) Reconnect cable W7P1 (fig. 1) to A10J2 (fig. 1) connector.

b. Adjustments

- (1) Position controls as listed in (a) through (e) below:
 - (a) **TUNING** control to **280 MHz**.
 - (b) **FREQ SPAN/DIV** switch to **200 kHz**.
 - (c) **RESOLUTION BW** switch to 1 MHz.
 - (d) INPUT ATTEN switch to 0 dB (OPTIMUM INPUT switch to -40 dBm).
 - (e) **REFERENCE LEVEL** switch to -20 dBm.
- (2) Connect CAL OUTPUT to INPUT 50Ω .

(3) Adjust **REF LEVEL FINE** control to position signal level 7.1 divisions above graticule baseline.

(4) Adjust A8R85 (fig. 5 for SN prefixed 2215A and below), (fig. 6 for SN prefixed 2332A), or A8R4 for SN prefixed 1707A (located on A8 board) to set bandwidth of 5 divisions wide at 5th graticule line above graticule baseline (R).

NOTE

Perform (5) through (21) below for SN prefixed 1707A only. Perform (22) through (44) below for SN prefixed 2332A, 2215A, and below.

(5) Set RESOLUTION BW switch to 100 kHz and FREQ SPAN/DIV switch to 20 kHz.

(6) Adjust signal level to 7.1 divisions with **REF LEVEL FINE** control.

(7) Adjust A8R3 (located on A8 board) for a 5-division wide signal at the 5th graticule line above graticule baseline (R).

(8) Set **RESOLUTION BW** switch to **30 kHz** and **FREQ SPAN/DIV** switch to **5 kHz**, and repeat (6) above.

(9) Adjust A8R2 (located on A8 board) for a 6 division wide signal at 5th graticule line above graticule baseline (R).

(10) Disconnect CAL OUTPUT from INPUT 50Ω.

(11) Disconnect W7P1 (red) cable from A10J2 connector (located on Al0 assembly) and connect signal generator RF output to W7P1 (red) cable.

(12) Adjust signal generator frequency to 301.4 MHz and RF output level controls to -30 dBm.

(13) Set **RESOLUTION BW** switch to **1 MHz** and adjust signal generator frequency controls to peak signal on crt.

(14) Adjust signal generator RF output level controls to position signal 7.1 divisions above graticule baseline.

(15) Set **RESOLUTION BW** switch to 1 kHz and adjust signal generator frequency controls to peak signal on crt.

(16) If signal is not positioned 7.1 graticules above graticule baseline, adjust A11R2 (located on A11 board) and A13R2 (located on A13 board) equally for a signal 7.1 divisions above graticule baseline(R).

(17) Record signal generator frequency.

(18) Adjust signal generator frequency 500 Hz below value recorded in (17) above.

(19) Adjust A8R1 (located on A8 board) to position the signal level on the 5th graticule line from the graticule baseline (R).

(20) Repeat (15) through (19) above until frequency change from center frequency at 7.1 divisions to the 3 dB point of the 5th graticule line is between 450 and 550 Hz.

(21) Connect W7P1 (red) cable to A10J2 (located on A10 assembly).

NOTE

Perform (22) through (44) below for SN prefixed 2332A, 2215A, and below.

(22) Set **RESOLUTION BW** and **FREQ SPAN/DIV** switches to settings as listed in table 6. If bandwidth at 5th graticule line above graticule baseline is not within the specified limits, perform (23) below.

(23) Adjust A8R85 (fig. 5 for SN prefixed 2215A and below) (fig. 6 for SN prefixed 2332A) for the best compromise for **300 kHz**, **1** and **3 MHz RESOLUTION BW** switch settings.

Test ins					
RESOLUTION BW	FREQ SPAN/ DIV	Bandwidth at			
switch	switch settings	5th graticule line			
settings	(kHz)	above graticule baseline			
3 MHz	500	5.4 to 6.6			
300 kHz	50	5.4 to 6.6			
100 kHz	20	4.3 to 5.7			
30 kHz	5	5.2 to 6.8			

Table 6. Bandwidth Adjustments

(24) Disconnect CAL OUTPUT from INPUT 50Ω.

(25) Disconnect W7P2 (red) cable (fig. 1) from A9J1 connector (fig. 1) and connect signal generator RF output to A9J1 (fig. 1).

(26) Adjust signal generator frequency to 301.4 MHz and RF output level controls to -30 dBm.

(27) Set **RESOLUTION BW** switch to 1 MHz and adjust signal generator frequency controls to peak signal on TI crt.

(28) Adjust signal generator RF output level controls to position signal 7.1 divisions above graticule baseline.

(29) Set **RESOLUTION BW** switch to **3 kHz** and adjust signal generator frequency controls to peak signal on TI crt. Record signal generator frequency.

(30) Adjust **REF LEVEL FINE** control to position signal 7.1 divisions above graticule baseline.

(31) Adjust signal generator frequency 1500 Hz below value recorded in (28) above. Record signal generator frequency.

(32) Adjust A8R72 (fig. 5 for SN prefixed 2215A and below) (fig. 6 for SN prefixed 2332A) to position signal 5 divisions above graticule baseline (R).

(33) Increase signal generator frequency until TI trace peaks and then drops to 5 divisions above graticule baseline. Record signal generator frequency.

(34) Subtract the value recorded in (31) above from the value recorded in (33) above. If the difference is not between 2800 and 3200 Hz, slightly readjust A8R72 (fig. 5 for SN prefixed 2215A and below) (fig. 6 for SN prefixed 2332A) and repeat (29) through (34) until the specified limits are achieved.

(35) Set **RESOLUTION BW** switch to **10 kHz** and adjust signal generator frequency controls to peak signal on TI crt.

(36) Position signal 7.1 divisions above graticule baseline with **REF LEVEL FINE** controls. Record signal generator frequency.

(37) Adjust signal generator frequency 5 kHz below frequency recorded in (36) above. Record signal generator frequency.

(38) Increase signal generator frequency until signal peaks and then decreases to the 5th division above graticule baseline. Record signal generator frequency.

(39) Subtract frequency recorded in (37) above from frequency recorded in (38) above, if difference is not between 9.000 and 11.000 kHz, slightly readjust A8R72 (fig. 5 for SN prefixed 2215A and below) (fig. 6 for SN prefixed 2332A) and repeat (35) through (39) until the specified limits are achieved.

NOTE

If A8R72 is adjusted in (39) above, the 3 kHz bandwidth must be between 2700 and 3300 Hz.

(40) Set **RESOLUTION BW** switch to 1 kHz and adjust signal generator frequency controls for a signal peak on TI crt.

(41) Position signal 7.1 divisions above graticule baseline with **REF LEVEL FINE** control. Record signal generator frequency.

(42) Increase signal generator frequency until signal on crt decreases to 5 divisions above graticule baseline. Record signal generator frequency.

(43) Subtract frequency recorded in (41) above from the frequency recorded in (42) above, the difference will be between 450 and 550 Hz.

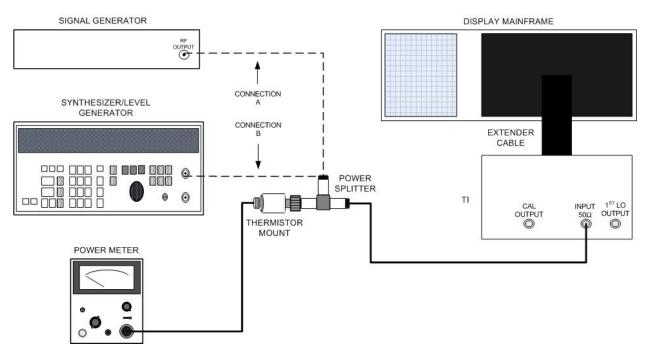
(44) Reconnect W7P2 (red) cable (fig. 1) to A9J1 (fig. 1).

12. Frequency Response

a. Performance Check

- (1) Position controls as listed in (a) through (e) below:
 - (a) **RESOLUTION BW** switch to 1 MHz.
 - (b) FREQ SPAN/DIV switch to 100 MHz.
 - (c) INPUT ATTEN switch to 20 dB (OPTIMUM INPUT switch to -20 dBm).
 - (d) **REFERENCE LEVEL** switch to **-10 dBm**.
 - (e) Press **1 dB/DIV** pushbutton in.

(2) Adjust **TUNING** control for an indication of 500 MHz on **FREQUENCY MHz** readout and press **FREQUENCY CAL** pushbutton.



(3) Connect equipment as shown in figure 10, connection A.

Figure 10. Frequency response - equipment setup.

(4) Adjust signal generator frequency controls to 500 MHz and RF output controls for a reference level signal peak on 6th division above graticule baseline.

(5) Record power meter indication (reference).

(6) Slowly adjust signal generator frequency and TI **TUNING** control from 80 to 1500 MHz while maintaining power meter reference level established in (5) above. The signal level will not exceed $\pm l$ division of 6th horizontal graticule line.

(7) Connect equipment as shown in figure 10, connection B.

(8) Set **RESOLUTION** switch to 100 kHz and FREQ SPAN/DIV switch to 1 MHz.

(9) Adjust TUNING control for 80 MHz indication on FREQUENCY MHz readout and press FREQUENCY CAL pushbutton.

(10) Adjust synthesizer/level generator frequency controls to 80~MHz and adjust amplitude controls to reference established in (4) above on TI.

(11) Slowly adjust synthesizer/level generator frequency and TI **TUNING** controls from 80 MHz to 100 kHz. The signal level will not exceed ± 1 division of 6th horizontal graticule line.

b. Adjustments. No adjustments can be made.

13. Input Attenuator

a. Performance Check

- (1) Connect synthesizer/level generator output 50 Ω to TI **INPUT 50** Ω .
- (2) Position controls as listed in (a) through (f) below:
 - (a) **TUNING** control to **30 MHz**.
 - (b) **REQ SPAN/DIV** switch to **200 kHz**.
 - (c) **RESOLUTION BW** switch to **30 kHz**.
 - (d) INPUT ATTEN switch to 70 dB (OPTIMUM INPUT switch to 30 dBm).
 - (e) **REFERENCE LEVEL** switch to **0 dBm**.
 - (f) VIDEO FILTER control to 2 o'clock position.

(3) Adjust synthesizer/level generator frequency controls to 30 MHz and amplitude controls to 0 dBm.

(4) Adjust signal peak to 6th horizontal line above graticule baseline with **REF** LEVEL FINE control (reference).

(5) Set **INPUT ATTEN** switch to settings as listed in table 7 and adjust synthesizer/level generator amplitude controls to position signal peak on 6th horizontal line above graticule baseline on TI crt. Synthesizer/level generator output amplitude display will indicate between specified limits.

b. Adjustments. No adjustments can be made.

	t Attenuators	
Test instrument		
OPTIMUM INPUT	Synthesizer/le amplitude disp	
switch settings	(dB	$m)^1$
(dBm)	Min	Max
20	-9.5	-10.5
10	-19.5	-20.5
0	-29.5	-30.5
	OPTIMUM INPUT switch settings (dBm) 20	OPTIMUM INPUTSynthesizer/le amplitude disp (dBm)switch settings(dBm)20-9.510-19.50-29.5

Table 7. Input Attenuators

See footnote at end of table.

Test instrument		Synthesizer/level generator	
0 dB INPUT ATTEN switch settings	OPTIMUM INPUT switch settings		lay indications
(dB)	(dBm)	Min	Max
30	-10	-39.5	-40.5
20	-20	-49.5	-50.5
10	-30	-59.5	-60.5
0	-40	-69.5	-70.5

Table 7. Input Attenuators - Continued

¹Maximum deviation will not exceed ±1.0 dB.

14. Reference Level Accuracy

a. Performance Check

NOTE

Verify the proper cal factors are loaded for the power sensor module being utilized.

- (1) Connect power sensor to power reference output. Perform sensor zero and calibration.
- (2) Connect equipment as shown in figure 11.

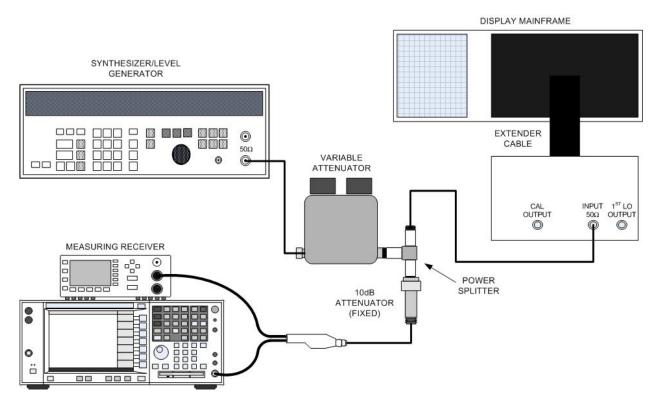


Figure 11. Reference level - equipment setup.

- (3) Position controls as listed in (a) through (g) below:
 - (a) INPUT ATTEN switch to 0 dB (OPTIMUM INPUT switch to -40 dBm).
 - (b) **TUNING** control to **30 MHz**.
 - (c) **FREQ SPAN/DIV** switch to **5 kHz**.
 - (d) **RESOLUTION BW** switch to **3 kHz**.
 - (e) **REFERENCE LEVEL** switch to -10 dBm.
 - (f) Press 1 dB/DIV pushbutton in.
 - (g) SWEEP TIME/DIV switch to AUTO.
- (4) Set variable attenuator to 0.

(5) Configure measuring receiver to measure frequency at .030 GHz with a 00.0 dBm attenuation reference.

(6) Adjust synthesizer/level generator frequency controls to 30 MHz and amplitude controls to -10 dBm.

(7) Perform (a) through (e) below if signal on crt is difficult to locate:

(a) Press **RESOLUTION BW** switch in to coupled position.

(b) Turn coupled controls (FREQ SPAN/DIV and RESOLUTION BW switches) cw until signal appears on crt.

- (c) Press **FREQUENCY CAL** pushbutton.
- (d) Center signal on crt with **TUNING** control.
- (e) Return controls to positions called out in (2) above.

(8) Position crt trace 6 divisions above graticule baseline with synthesizer/level generator amplitude controls (reference).

(9) Adjust synthesizer/level generator amplitude output controls and variable attenuator switch settings to position crt trace to reference established in (6) above while setting **REFERENCE LEVEL** switch to values listed in table 8. If measuring receiver does not indicate within specified limits, perform **b** below.

(10) Press LIN pushbutton in and repeat (3) through (9) above.

Table 6. Reference Level (Log) Recuracy			
Test instrument REFERENCE LEVEL switch settings	Variable attenuator 10 dB step control setting	indica	g receiver tions ¹ B)
(dBm)	(dB)	Min	Max
-20	10	9.5	10.5
-30	20	19.5	20.5
-40	30	29.5	30.5
-50	40	39.5	40.5
-60	50^{2}	49.5	50.5
-70	60	59.5	60.5
-80	70	69.5	70.5

Table 8. Reference Level (Log) Accuracy

¹Variable attenuator error must be added algebraically. ²Reduce synthesizer/level generator attenuator setting.

b. Adjustments

NOTE

Adjustment steps (1) through (27) below are used for SN prefix 2436A only.

Adjustment steps (28) through (52) below are used for SN prefix 2332A and below.

(1) Connect equipment as shown in figure 12.

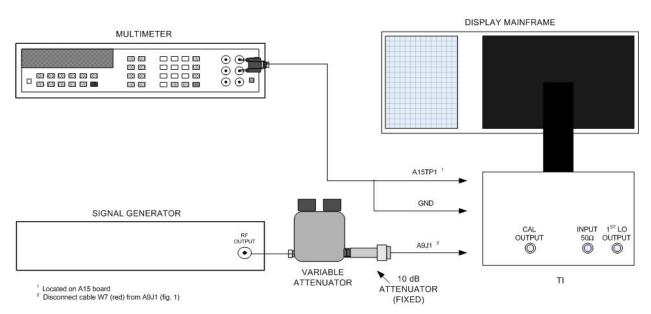


Figure 12. Log amplifier adjustments - equipment setup.

- (2) Position controls as listed in (a) through (e) below:
 - (a) **FREQ SPAN/DIV** switch to **0**.

- (b) **RESOLUTION BW** switch to **300 kHz**.
- (c) INPUT ATTEN switch to 10 dB (OPTIMUM INPUT switch to -30 dBm).
- (d) **REFERENCE LEVEL** switch to **-50 dBm**.
- (e) Press LIN pushbutton in.

(3) Set variable attenuator 10 dB STEP control to 0 dB.

(4) Adjust signal generator frequency controls to 301.4 MHz and RF output level to -13 dBm.

(5) Set **TEST/NORM** switch (located on Al2 board) to **TEST** position.

(6) Adjust signal generator frequency controls for a maximum signal amplitude display on crt. (Reduce signal generator RF output if necessary).

(7) Press signal generator power switch to STBY position. Record multimeter indication as offset value.

(8) Press signal generator power switch to on position and adjust RF output controls for a multimeter indication of 800 mV, ± 1 mV (plus offset value recorded in (7) above).

EXAMPLE #1: If offset value ((7) above) is +15 mV (dc): 800 mV <u>+15 mV</u> +815 mV (dc)

THEN: Adjust signal generator amplitude output controls for +815 mV indication on multimeter.

EXAMPLE #2: If offset value ((7) above) is -15 mV (dc): 800 mV -<u>15 mV</u> 785 mV (dc)

THEN: Adjust signal generator amplitude output controls for +785 mV indication on multimeter.

(9) Press **10 dB/DIV** pushbutton in and adjust A14R23 (fig. 13) for a multimeter indication of 800 mV, ± 1 mV (plus offset value recorded in (7) above) (R).

(10) Set variable attenuator 10 dB step control to 60 dB and adjust A14R10 (fig. 13) for a multimeter indication of 200 mV, \pm l mV (plus offset voltage recorded in (7) above (R).

(11) Set variable attenuator 10 dB step control to 0.

(12) Repeat (9) through (11) above until no further adjustment is required.

(13) Set variable attenuator 10 dB step control to 30 dB and adjust A14R23 (fig. 13) for a multimeter indication of 500 mV, ± 1 mV (plus offset voltage recorded in (7) above) (R).

(14) Set variable attenuator 10 dB step control to 0 dB and adjust A14R69 (fig. 13) for a multimeter indication of 800 mV \pm l mV, (plus offset voltage recorded in (7) above) (R).

(15) Repeat (13) and (14) above until no further adjustment is required.

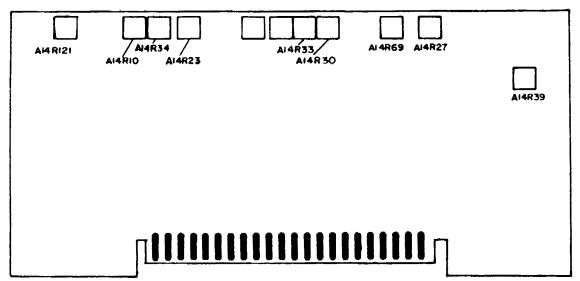


Figure 13. A14 log amplifier assembly adjustment locations for SN prefix 2436A.

(16) Set variable attenuator 10 dB step control to 10 dB and adjust A14R23 (fig. 13) for a multimeter indication of 700 mV, \pm l mV (plus offset voltage recorded in (7) above) (R).

(17) Set variable attenuator 10 dB step control to 0 dB and adjust A14R39 (fig. 13) for a multimeter indication of 800 mV, \pm l mV (plus offset voltage recorded in (7) above) (R).

(18) Repeat (16) and (17) above until no further adjustment is required.

(19) Set variable attenuator 10 dB step control to settings as listed in table 9. If multimeter does not indicate within specified limits, repeat (9) through (18) above.

Variable attenuator 10 dB step control settings	Table 9. Log Fidelity Check Multimeter indication (plus offset recorded in (7) above (MV)	
(dB)	Min	Max
0	799	801
10	697	703
20	596	604
30	496	504
40	395	405
50	294	306
60	193	207
70	92	108

Table O. Law Eidalitz Obash

(20) Set REFERENCE LEVEL switch to -50 dBm and press LIN pushbutton in.

(21) Set variable attenuator 10 dB step control to 0 dB and adjust A14R34 (fig. 13) for a multimeter indication of 800 mV \pm 1 mV (plus offset voltage recorded in (7) above) (R).

(22) Set **REFERENCE LEVEL** switch and variable attenuator 10 dB step control to settings as listed in table 10. If multimeter indication is not within specified limits, perform adjustment listed.

(23) Set **REFERENCE LEVEL** switch to -50 dBm and press 1 dB/DIV pushbutton in.

(24) Set variable attenuator 10 dB step control to 0 dB and adjust signal generator RF output controls for a multimeter indication of 800 mV, ± 1 mV (plus offset voltage recorded in (7) above).

(25) Set variable attenuator 10 dB step control to 40 dB.

(26) Set **REFERENCE LEVEL** switch to **-90 dBm** and adjust A14R121 (fig. 13) for a multimeter indication of 800 mV, ±3 mV (plus offset voltage recorded in (7) above) (R).

(27) Return A12S1**TEST/NORM** switch (located on A12 board) to **NORM**. Remove test cable and reconnect W7 (red) cable to A9J1 (fig. 1).

NOTE

Adjustment steps (28) through (52) below are used for SN prefix 2142A and below.

(28) Position controls as listed in (a) through (e) below:

- (a) FREQ SPAN/DIV switch to 1 MHz.
- (b) **RESOLUTION BW** switch to **300 kHz**.
- (c) **OPTIMUM INPUT** switch to **-30 dBm**.

(d) **REFERENCE LEVEL dBm** switch to -50.

Table 10. Linear Gain Adjustments				
Test instrument REFERENCE LEVEL dBm switch settings	Variable attenuator 10 dB step control setting	voltage record	cations plus offset ded in (7) above AV)	Adjustments (fig. 12)
(dBm)	(dB)	Min	Max	
-50	0	799	801	A14R34(R)
-60	10	795	805	A14R33(R)
-70	20	795	805	A14R30(R)
-80	30	795	805	A14R27(RO
-90	40	790	810	

(e) Press LIN pushbutton in.

Table 10. Linear Gain Adjustments

(29) Connect equipment as shown in figure 12.

(30) Set variable attenuator 10 dB step control to 0 dB.

(31) Adjust signal generator frequency controls to 301.4 MHz and RF output level to -13 dBm.

(32) Set TEST/NORM switch (located on A12 board) to TEST position.

(33) Adjust signal generator frequency controls for a maximum signal amplitude display on crt. (Reduce signal generator RF output, if necessary.)

(34) Adjust signal generator RF output controls for a multimeter indication of 700 mV.

(35) Set **REFERENCE LEVEL** switch to -80 dBm.

(36) Set variable attenuator 10 dB step control to 30 dB and adjust A14R3 (fig. 14) for a multimeter indication of 700 mV (R).

(37) Repeat (34) through (36) above until multimeter indication is between 698 and 702 mV.

(38) Set **REFERENCE LEVEL** switch to -50 dBm.

(39) Set variable attenuator 10 dB step control to 0 dB.

(40) Set **REFERENCE LEVEL** switch and variable attenuator 10 dB step control to settings as listed in table 11. If any deviation from reference is not within specified limits, readjust A14R3 (fig. 14) for best (in limits) compromise (R).

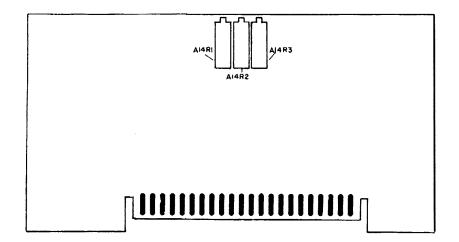


Figure 14. A14 log amplifier - adjustment locations (SN prefix 2142A and below).

Table 11. Linear Gain				
Test instrument	Variable			
REFERENCE LEVEL	attenuator	Deviation from		
dBm	10 dB step	crt		
switch settings	control setting	reference ¹		
(dBm)	(dB)			
-50	0	±2 div		
-60	10	± 2 div		
-70	20	± 2 div		
-80	30	±2 div		
-90	40	± 2 div		

(41) Set signal generator RF output to STBY position. Record multimeter indication as offset value.

(42) Set signal generator RF output to on and press TI 10 dB/DIV pushbutton in.

(43) Set variable attenuator 10 dB step control to 40 dB and adjust signal generator RF output controls for a multimeter indication of 400 mV plus offset value recorded in (41) above. (Refer to (8) above for examples on adding offset value to multimeter indication).

(44) Set variable attenuator 10 dB step control to 0 dB. Multimeter will indicate 800 mV, ± 1 mV (plus offset value recorded in (41) above). If not, adjust A14R2 (fig. 14) for a multimeter indication of 800 mV plus offset value recorded in (41) above (R).

(45) Set variable attenuator 10 dB step control to values as listed in table 12. Record multimeter indication for each variable attenuator 10 dB step control setting. Correct multimeter indications by algebraically adding offset value recorded in (41) above and adjust A1 4R2 (fig. 14) to meet limits listed in table 12 (R).

Table 12. Log Fidelity		
Variable attenuator	Multimeter	
10 dB step	indications	
control settings	corrected for offset	
(dB)	(MV)	
0	800 + offset ±l m V	
10	$700 + \text{offset } \pm 3 \text{ mv}$	
20	$600 + \text{off set } \pm 4 \text{ mV}$	
30	$500 + \text{offset} \pm 4 \text{ mV}$	
40	$400 + \text{offset} \pm 5 \text{ mV}$	
50	$300 + \text{offset} \pm 4 \text{ mV}$	
60	$200 + \text{offset} \pm 7 \text{ mV}$	

NOTE See examples 1 and 2 in **b** (8) above.

(46) Set **REFERENCE LEVEL** switch to -50.

(47) Press 1 dB/DIV pushbutton in and set variable attenuator 10 dB step control to 0 dB.

(48) Adjust signal generator RF output controls for a multimeter indication of 700 mV (do not include offset value).

(49) Set **REFERENCE LEVEL** switch to -90.

(50) Set variable step attenuator 10 dB step control to 40 dB and adjust A14R1 (fig. 14) for a multimeter indication of 700 mV (do not add offset value) (R).

(51) Set **REFERENCE LEVEL** switch and variable attenuator to settings as listed in table 13. If any deviation from reference is not within specified limits adjust A14Rl (fig. 13) for best (in limits) compromise (R).

Table 13. Log Gain		
Test instrument REFERENCE LEVEL dBm switch settings (dBm)	Variable attenuator 10 dB step control settings (dB)	Deviation from crt reference ¹
-50	0	0.3 div
-60	10	0.3 div
-70	20	0.3 div
-80	30	0.3 div
-90	40	0.3 div

¹Variable attenuator errors must be added algebraically.

(52) Return **TEST/NORM** switch (located on A12 board) to **NORM**. Remove test cable and reconnect W7 (red) cable to A9J1 (fig. 1).

15. Residual FM Test

a. Performance Check

- (1) Position controls as listed in (a) through (e) below:
 - (a) **FREQ SPAN/DIV** switch to **100 kHz**.
 - (b) **RESOLUTION BW** switch to **10 kHz**.
 - (c) INPUT ATTEN switch to 0 dB (OPTIMUM INPUT switch to -40 dBm).
 - (d) **REFERENCE LEVEL** switch to -20 dBm.
 - (e) Press LIN pushbutton in.
- (2) Connect comb generator output to **INPUT 50** Ω .

NOTE

Increase **INPUT ATTEN** switch setting if comb generator signal amplitude overdrives crt indication.

(3) Adjust **TUNING** control to center 500 MHz signal on crt and press **FREQUENCY CAL** pushbutton.

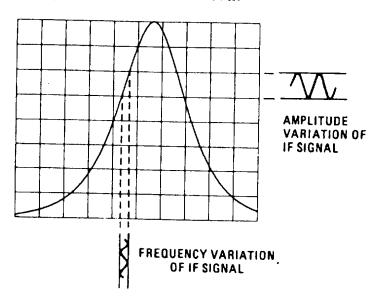
(4) Position signal peak at top crt horizontal line (fig. 15) with **REFERENCE LEVEL** switch and **REF LEVEL FINE** control.

(5) Maintain signal center on crt with **TUNING** control while reducing **FREQ SPAN/ DIV** switch to **0**.

(6) Set **RESOLUTION BW** switch to **10 kHz** and **SWEEP TIME/DIV** switch to **.1s**.

(7) Slightly adjust **TUNING FINE** control until trace appears between 4th and 7th vertical graticule from graticule baseline. Peak-to-peak variation of trace will not exceed one major vertical division for each major horizontal division.

b. Adjustments. No adjustments can be made.



Shape of 10 kHz Resolution BW Filter



16. Noise Sidebands Test

a. Performance Check

- (1) Position controls as listed in (a) through (g) below:
 - (a) **TUNING** control to **400 MHz**.
 - (b) **FREQ SPAN/DIV** switch to 1 MHz.
 - (c) **RESOLUTION BW** switch to **30 kHz**.
 - (d) INPUT ATTEN switch to 10 dB (OPTIMUM INPUT switch to -30 dBm).
 - (e) **REFERENCE LEVEL** switch to -20 dBm.
 - (f) Press 10 dB/DIV pushbutton in.
 - (g) SWEEP TIME/DIV switch to AUTO.
- (2) Connect signal generator RF output to TI INPUT 50Ω .

(3) Adjust signal generator frequency controls for 400 MHz and RF output controls for -20 dBm.

(4) Center signal on crt with **TUNING** control.

(5) Position signal peak at top crt horizontal graticule line with **REFERENCE LEVEL** and **REF LEVEL FINE** controls.

(6) Maintain signal center with **TUNING** control while setting **FREQ SPAN/ DIV** switch to **20 kHz** and **RESOLUTION BW** switch to **1 kHz**.

(7) Turn **VIDEO FILTER** control fully cw (not in detent).

(8) Measure noise sidebands existing more than 2.5 divisions (50 kHz) from 400 MHz signal. Noise sidebands will be greater than 65 dB (6.5 divisions) down from top horizontal graticule line.

b. Adjustments. No adjustment can be made.

17. Final Procedure

a. Deenergize and disconnect all equipment.

b. Annotate and affix DA label/form in accordance with TB 750-25.

By Order of the Secretary of the Army:

GEORGE W. CASEY, JR. General, United States Army Chief of Staff

Official: the n JOYCE E. MORROW

Administrative Assistant to the Secretary of the Army 0719023

Distribution:

To be distributed in accordance with the initial distribution number (IDN) 344234, requirements for calibration procedure TB 9-6625-2235-24.

INSTRUCTIONS FOR SUBMITTING AN ELECTRONIC 2028

The following format must be used if submitting an electronic 2028. The subject line must be exactly the same and all fields must be included; however, only the following fields are mandatory: 1, 3, 4, 5, 6, 7, 8, 9, 10, 13, 15, 16, 17, and 27.

From: "Whomever" <u>whomever@redstone.army.mil</u> To: <2028@redstone.army.mil

Subject: DA Form 2028

- 1. From: Joe Smith
- 2. Unit: home
- 3. Address: 4300 Park
- 4. City: Hometown
- 5. St: MO
- 6. Zip: 77777
- 7. **Date Sent**: 19-OCT –93
- 8. **Pub no:** 55-2840-229-23
- 9. Pub Title: TM
- 10. Publication Date: 04-JUL-85
- 11. Change Number: 7
- 12. Submitter Rank: MSG
- 13. Submitter FName: Joe
- 14. Submitter MName: T
- 15. Submitter LName: Smith
- 16. Submitter Phone: 123-123-1234
- 17. **Problem**: 1
- 18. Page: 2
- 19. Paragraph: 3
- 20. Line: 4
- 21. NSN: 5
- 22. Reference: 6
- 23. Figure: 7
- 24. Table: 8
- 25. Item: 9
- 26. Total: 123
- 27. Text

This is the text for the problem below line 27.